



Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from,Europe,America and south Asia,supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of “Quality Parts,Customers Priority,Honest Operation,and Considerate Service”,our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip,ALPS,ROHM,Xilinx,Pulse,ON,Everlight and Freescale. Main products comprise IC,Modules,Potentiometer,IC Socket,Relay,Connector.Our parts cover such applications as commercial,industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



## Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

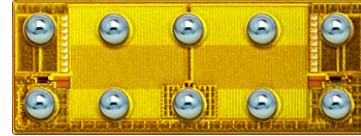
Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China



## Preliminary Datasheet

### FEATURES:

- Integrated Gate Driver
  - Low Propagation Delay
  - Up to 7 MHz Operation
  - Operates from 5 V Supply
- Dual 88-mΩ, 150-V eGaN FET
- Low Inductance 2.9 mm x 1.1 mm BGA



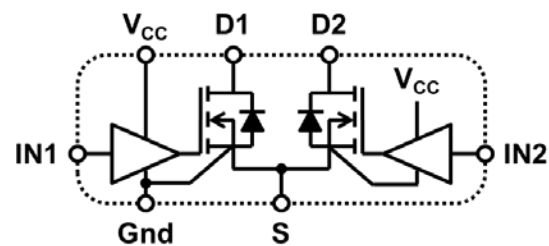
EPC2115 devices are supplied only in passivated die form with solder balls

**Die Size: 2.9 mm x 1.1 mm**

### APPLICATIONS:

- Wireless Power (Highly Resonant and Inductive)
- High Frequency DC-DC Conversion

### Schematic Diagram



### DESCRIPTION

The EPC2115 enhancement-mode gallium-nitride (eGaN®) monolithic IC contains two monolithic 88-mΩ, 150-V GaN power transistors, each with an optimized gate driver, in a low inductance 2.9 mm by 1.1 mm BGA package.

The EPC2115 enables designers to improve efficiency, save space, and lower costs compared to silicon-based solutions. The ultra-low capacitance and zero reverse recovery of the eGaN FETs enable efficient operation in many topologies. The integrated drivers are specifically matched to the GaN device to yield optimal performance under various operating conditions that is further enhanced due to the small, low inductance footprint. Monolithic integration eliminates interconnect inductances for higher efficiency at high frequency. This is especially important for high frequency applications such as resonant wireless power.

## ABSOLUTE MAXIMUM RATINGS

Maximum Ratings			
V <sub>DS</sub>	Drain-to-Source Voltage (Continuous)	150	V
I <sub>D</sub>	Continuous (T <sub>A</sub> = 25°C, R <sub>θJA</sub> = 32 °C/W)	5	A
	Pulsed (25°C, T <sub>PULSE</sub> 300 μs)	18	
V <sub>IN</sub>	Input Signal Voltage	6	V
T <sub>J</sub>	Operating Temperature	-40 to 150	°C
T <sub>STG</sub>	Storage Temperature	-40 to 150	
V <sub>CC</sub>	Supply Voltage	6	V

## RECOMMENDED OPERATING CONDITIONS

Recommended Operating Conditions					
PARAMETER	Description	MIN	TYP	MAX	UNIT
V <sub>DS</sub>	Drain-Source voltage			120	V
V <sub>CC</sub>	Driver Supply voltage	4.5	5	5.5	V
I <sub>CC</sub>	External driver supply current <sup>1</sup>			60	mA
V <sub>IN,off</sub>	Input signal for turn-off			0.5	v
V <sub>IN,on</sub>	Input signal for turn-on	4.5			V
V <sub>IN,slew</sub>	Input signal slew rate	0.25			V/ns
T <sub>J</sub>	Operating Temperature	-40		150	°C

<sup>1</sup> For up to maximum operating frequency and to power both FETs

## THERMAL INFORMATION

Thermal Characteristics			
		TYP	Unit
R <sub>θJC</sub>	Thermal Resistance, Junction to Case	2.1	°C/W
R <sub>θJB</sub>	Thermal Resistance, Junction to Board	21	°C/W
R <sub>θJA</sub>	Thermal Resistance, Junction to Ambient <sup>2</sup>	66	°C/W

<sup>2</sup> R<sub>θJA</sub> is determined with the device mounted on one square inch of copper pad, single layer 2 oz copper on FR4 board. Thermal models for EPC devices available at <http://epc-co.com/epc/DesignSupport/DeviceModels.aspx>

# EPC2115 – Dual 150 V, 5 A Integrated Gate Drivers eGaN® IC



## ELECTRICAL CHARACTERISTICS

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	Unit
<b>eGaN POWER TRANSISTOR</b>					
$BV_{DSS}$	Drain-to-Source Voltage	$V_{CC} = 0\text{ V}, V_{IN} = 0\text{ V}, I_D = 125\ \mu\text{A}$	150		V
$I_{DSS}$	Drain -Source Leakage	$V_{DS} = 120\text{ V}, T_J = 25\text{ }^\circ\text{C}$		10	$\mu\text{A}$
$R_{DS(ON)}$	Drain-Source On-Resistance	$V_{CC} = 5\text{ V}, T_J = 25\text{ }^\circ\text{C}$		70	$\text{m}\Omega$
$V_{SD}$	Source-Drain Forward Voltage	$V_{CC} = 5\text{ V}, V_{IN} = 0\text{ V}, I_{SD} = 0.5\text{ A}$		2	V
$C_{OSS}$	Output Capacitance	$V_{IN} = 0\text{ V}, V_{CC} = 5\text{ V}, V_{DS} = 75\text{ V}, f = 1\text{ MHz}$		57	pF
$C_{OSS(ER)}$	Energy Output Capacitance, Energy Related <sup>3</sup>	$V_{IN} = 0\text{ V}, V_{CC} = 5\text{ V}, V_{DS} = 0\text{ to }75\text{ V}$		111	
$C_{OSS(TR)}$	Energy Output Capacitance, Energy Related <sup>4</sup>			108	
$Q_{OSS}$	Output Charge	$V_{IN} = 0\text{ V}, V_{CC} = 5\text{ V}, V_{DS} = 75\text{ V}, V_{GS} = 0\text{ V}$		6.7	nC
$Q_{RR}$	Source-Drain Recovery Charge			0	
<sup>3</sup> $C_{OSS(ER)}$ is a fixed capacitance that gives the same stored energy as $C_{OSS}$ while $V_{DS}$ is rising from 0 to 50% $BV_{DSS}$					
<sup>4</sup> $C_{OSS(TR)}$ is a fixed capacitance that gives the same charging time as $C_{OSS}$ while $V_{DS}$ is rising from 0 to 50% $BV_{DSS}$					

## ELECTRICAL CHARACTERISTICS

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	Unit
<b>DRIVER SUPPLY</b>					
$I_{VCC,ON}$	Quiescent current (average)	$V_{IN} = 5\text{ V}, V_{CC} = 5\text{ V}, V_{DS} = 0\text{ V}$ , each FET-driver		4.4	mA
$I_{VCC,OFF}$	Quiescent current (average)	$V_{IN} = 0\text{ V}, V_{CC} = 5\text{ V}, V_{DS} = 0\text{ V}$ , each FET-driver		4.4	
$I_{VCC,OP}$	Operating Current	50% duty cycle, $V_{CC} = 5\text{ V}, f_{SW} = 1\text{ MHz}$ , each FET-driver		6.5	
$V_{IH}$	Turn-on Input pin, logic high	$V_{CC} = 5\text{ V}$ , each FET-driver	4.0		V
$V_{IL}$	Turn-off Input pin, logic low	$V_{CC} = 5\text{ V}$		0.7	

## SWITCHING CHARACTERISTICS

Switching Characteristics					
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>DRIVER<sup>5</sup></b>					
$t_{pd,on}$	Propagation delay, turn on	$V_{CC} = 5\text{ V}, V_{DS} = 120\text{ V}, I_L = 2\text{ A}$	2.6		ns
$t_{rise}$	Rise Time		2.3		ns
$t_{on}$	Total turn-on time		6.8		ns
$t_{pd,off}$	Propagation delay, turn off		10.1		ns
$t_{fall}$	Fall Time		3.7		ns
$t_{off}$	Total turn-off time		16.4		ns
$t_{MIN}$	Minimum on-time		$V_{CC} = 5\text{ V}, V_{BUS} = 120\text{ V}$	9.2	
$t_{MAX}$	Maximum on-time	$V_{CC} = 5\text{ V}, I_{DS} = 0.5\text{ A}$	40		ms

<sup>5</sup>See application circuit, Figure 4 & 5

## TYPICAL CHARACTERISTICS

Figure 1: Normalized On-State Resistance vs Temperature

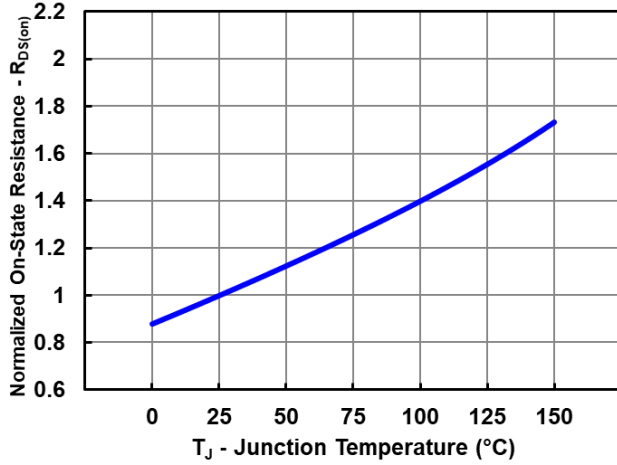


Figure 2: Capacitance (Linear Scale)

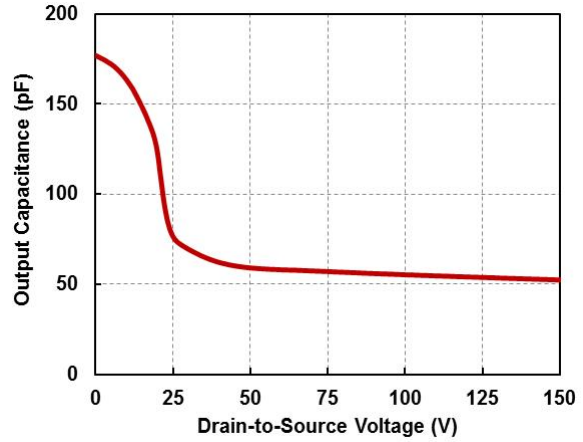


Figure 3: Output Charge and  $C_{OSS}$  Stored Energy

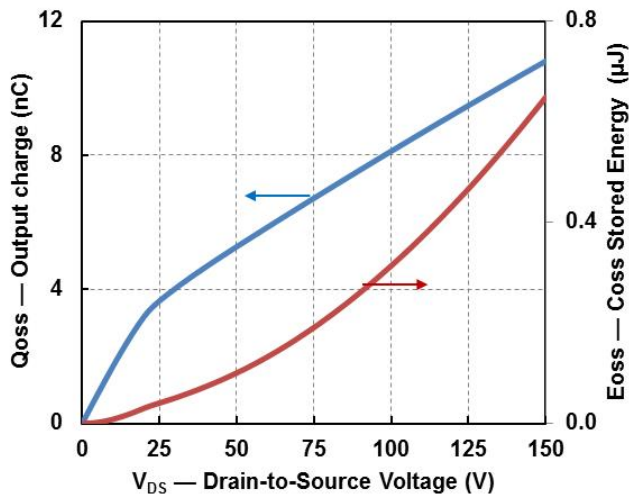


Figure 4: Double pulse Test Definitions

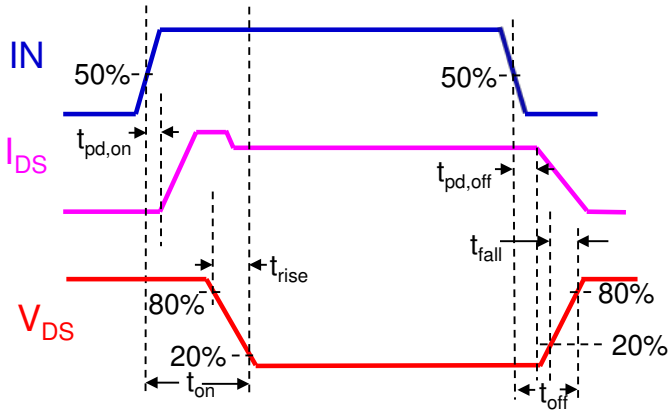


Figure 5: Double pulse Test Circuit

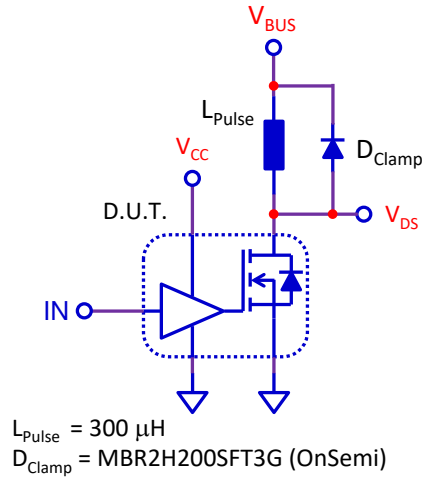


Figure 6: Driver quiescent current as function of frequency

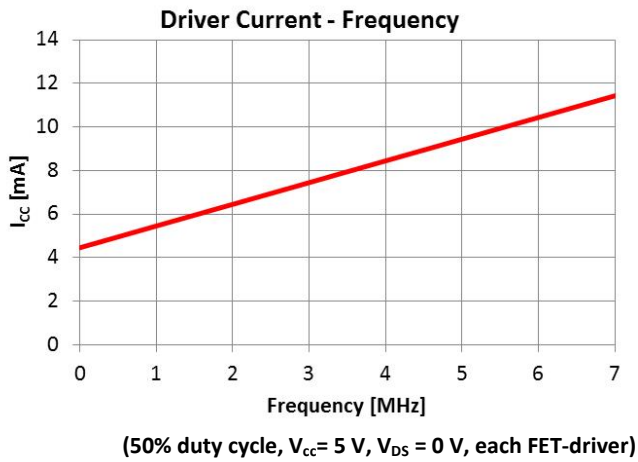
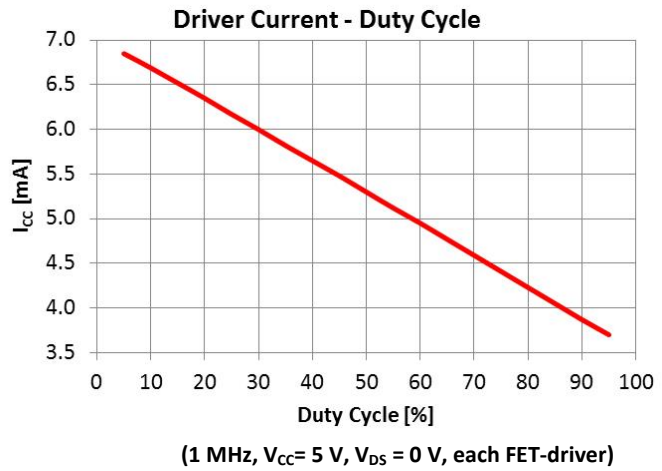


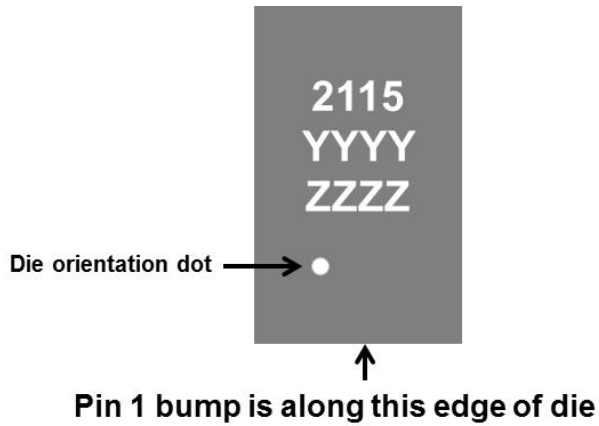
Figure 7: Driver quiescent current as function of duty cycle



# EPC2115 – Dual 150 V, 5 A Integrated Gate Drivers eGaN® IC



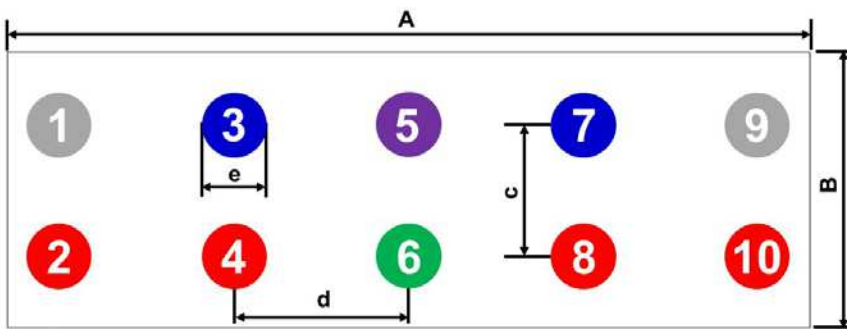
## DIE MARKINGS



Part Number	Laser Marking		
	Part # Marking Line 1	Lot Date Code Marking Line 2	Lot Date Code Marking Line 3
EPC2115ENGRT	2115	YYYY	ZZZZ

## DIE OUTLINE

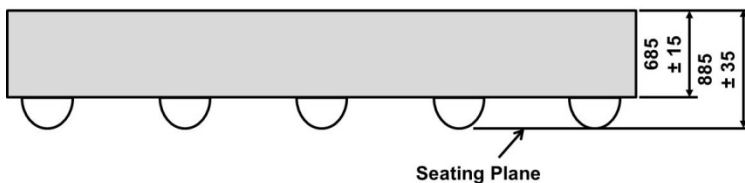
### Solder Bump View



DIM	MICROMETERS		
	MIN	Nominal	MAX
A	2870	2900	2930
B	1070	1100	1130
c		600	
d		600	
e	238	264	290

Pad 1 is Input 1;  
 Pad 9 is Input 2;  
 Pad 6 is  $V_{CC}$ ;  
 Pad 5 is Gnd;  
 Pads 2, 4 are Drain 1;  
 Pads 8, 10 are Drain 2;  
 Pads 3, 7 are Source

### Side View

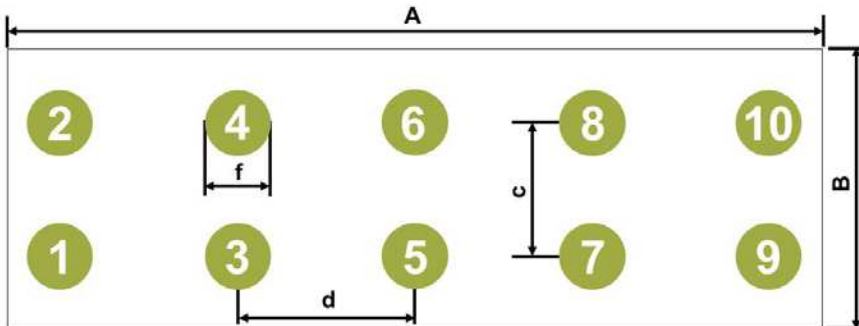


# EPC2115 – Dual 150 V, 5 A Integrated Gate Drivers eGaN® IC



## RECOMMENDED LAND PATTERN

(Units in  $\mu\text{m}$ )



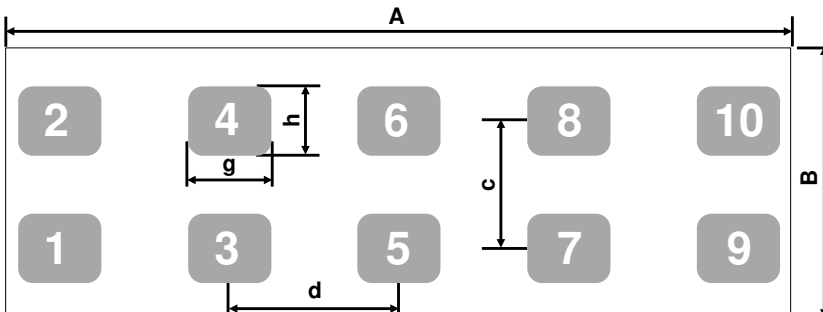
DIM	MICROMETERS
A	2900
B	1100
c	600
d	600
f	230

The land pattern is solder mask defined. Copper is larger than the solder mask opening.

## RECOMMENDED STENCIL DESIGN

(Units in  $\mu\text{m}$ )

Back Side View (Bump on Bottom)



DIM	MICROMETERS
A	2900
B	1100
c	600
d	600
g	300
h	250

Intended for use with SAC305 Type 4 solder, reference 88.5% metals content.

Recommended stencil should be 4mil (100 $\mu\text{m}$ ) thick, laser cut. The corner has a radius of R60.

Additional assembly resources available at <http://epc-co.com/epc/DesignSupport/AssemblyBasics.aspx>

Efficient Power Conversion Corporation (EPC) reserves the right to make changes without further notice to any products herein. Preliminary specification sheet contains informaton regarding a product EPC is considering for production release. EPC does not assume any liability arising out of the application or use of any product or circuit described herein; neither does it convey any license under its patent rights, nor the rights of other.

eGaN® is a registered trademark of Efficient Power Conversion Corporation.

EPC Patents: <http://epc-co.com/epc/AboutEPC/Patents.aspx>

March, 2018